

Search Notes

Application/Control No.

10/825,531

Examiner

Leigh C. Maier

Applicant(s)/Patent under
Reexamination

SHINKAI ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner
558	240-243 246 250 254-258	6/29/2006	LCM
564	84 154	6/29/2006	LCM
564	166	6/29/2006	LCM
564	188-191	6/29/2006	LCM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
-STN structure seacrh	6/29/2006	LCM